Issue Classification



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Examiner

Kröfcheck, Michael

Applicant(s)/Patent Under Reexamination

CHOI ET AL.

Art Unit

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Krofcheck, Michael (Assistant Examiner) (Date)											Total Claims Allowed: 66					
(Legal Inst Examiner)	ruments	MAITHEW KIM SUPERVISORY PATENT EXAMINER (PTEGHNEXLAGGER/CENTER 2100 (Date) / 2/07						O.G. Print Claim(s) 81				O.G. Print Figure				